# International **TOR** Rectifier

### AUTOMOTIVE GRADE

## AUIRF1405ZS AUIRF1405ZL

#### Features

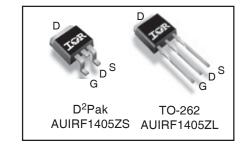
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*

#### Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low onresistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

#### HEXFET<sup>®</sup> Power MOSFET

G S	V <sub>(BR)DSS</sub>	55V
	R <sub>DS(on)</sub> max.	<b>4.9m</b> Ω
	I <sub>D</sub>	150A



G	D	S
Gate	Drain	Source

#### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature ( $T_A$ ) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	150	
$I_D @ T_C = 100^{\circ}C$	Continuous Drain Current, V <sub>GS</sub> @ 10V	110	A
I <sub>DM</sub>	Pulsed Drain Current ①	600	
$P_{D} @ T_{C} = 25^{\circ}C$	Power Dissipation	230	W
	Linear Derating Factor	1.5	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) 2	270	mJ
E <sub>AS</sub> (tested)	Single Pulse Avalanche Energy Tested Value 6	420	
I <sub>AR</sub>	Avalanche Current ①	See Fig.12a, 12b, 15, 16	A
E <sub>AR</sub>	Repetitive Avalanche Energy ©		mJ
TJ	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

#### **Thermal Resistance**

	Parameter	Тур.	Max.	Units
R <sub>0JC</sub>	Junction-to-Case		0.65	°C/W
R <sub>0JA</sub>	Junction-to-Ambient (PCB Mount, steady state)	_	40	

 $<sup>\</sup>mathsf{HEXFET}^{\texttt{®}}$  is a registered trademark of International Rectifier.

<sup>\*</sup>Qualification standards can be found at http://www.irf.com/

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	55	· yp.		V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.049		V/°C	Reference to 25°C, $I_D = 1mA$
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		3.7	4.9	mΩ	$V_{GS} = 10V, I_D = 75A$ ③
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0	5.7	4.9	V	$V_{GS} = V_{GS}, I_D = 250 \mu A$
	Forward Transconductance			4.0	S	
gfs		88			-	$V_{DS} = 25V, I_D = 75A$
DSS	Drain-to-Source Leakage Current			20	μA	$V_{DS} = 55V, V_{GS} = 0V$
				250		$V_{DS} = 55V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			200	nA	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-200		V <sub>GS</sub> = -20V
Dynamic E	lectrical Characteristics @ T <sub>J</sub> =	= 25°C	(unle	ss oth	nerwis	e specified)
Q <sub>g</sub>	Total Gate Charge		120	180		I <sub>D</sub> = 75A
Q <sub>gs</sub>	Gate-to-Source Charge		31		nC	$V_{DS} = 44V$
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge		46		1	V <sub>GS</sub> = 10V ③
t <sub>d(on)</sub>	Turn-On Delay Time		18			$V_{DD} = 25V$
t <sub>r</sub>	Rise Time		110		1	I <sub>D</sub> = 75A
t <sub>d(off)</sub>	Turn-Off Delay Time		48		ns	$R_G = 4.4\Omega$
t <sub>f</sub>	Fall Time		82		1	V <sub>GS</sub> = 10V ③
L <sub>D</sub>	Internal Drain Inductance		4.5			Between lead,
-			_		nH	6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance		7.5			from package
0						
C <sub>iss</sub>	Input Capacitance		4780			and center of die contact s V <sub>GS</sub> = 0V
C <sub>oss</sub>	Output Capacitance		770		1	$V_{\rm DS} = 25V$
C <sub>rss</sub>	Reverse Transfer Capacitance		410		pF	f = 1.0MHz
C <sub>oss</sub>	Output Capacitance		2730			$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
C <sub>oss</sub>	Output Capacitance		600			$V_{GS} = 0V, V_{DS} = 44V, f = 1.0MHz$
C <sub>oss</sub> eff.	Effective Output Capacitance		910			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 44V $
	racteristics		510			
Didue Cila	_	Min.	Tun	Mox	Units	Conditions
1-	Parameter Continuous Source Current	IVIIII.	Тур.	Max.	Units	MOSFET symbol
I <sub>S</sub>				75		
1	(Body Diode)			600	A	showing the
I <sub>SM</sub>	Pulsed Source Current			600		integral reverse
<b>X</b>	(Body Diode) ①					p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage	<u> </u>		1.3	V	$T_J = 25^{\circ}C, I_S = 75A, V_{GS} = 0V$ (3)
t <sub>rr</sub>	Reverse Recovery Time		30	46	ns	$T_J = 25^{\circ}C, I_F = 75A, V_{DD} = 25V$
Q <sub>rr</sub>	Reverse Recovery Charge		30	45	nC	di/dt = 100A/µs
t <sub>on</sub>	Forward Turn-On Time	Intrinsio	c turn-or	n time is	negligib	le (turn-on is dominated by LS+LD)

#### Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

#### Notes:

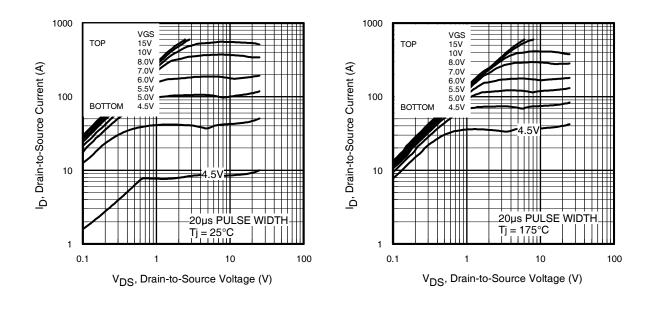
- Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ③ Pulse width  $\leq$  1.0ms; duty cycle  $\leq$  2%.
- 4 C\_{oss} eff. is a fixed capacitance that gives the same charging time as C\_{oss} while V\_{DS} is rising from 0 to 80% V\_{DSS}.
- ⑤ Limited by T<sub>Jmax</sub>, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- black This value determined from sample failure population, starting T\_J = 25°C, L = 0.10mH, R\_G = 25\Omega, I\_{AS} = 75A, V\_{GS} =10V.
- ⑦ This is applied to D<sup>2</sup>Pak, when mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.

#### Qualification Information<sup>†</sup>

		Automotive			
		(per AEC-Q101) <sup>††</sup>			
		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
Moisture Sensitivity			N/A		
		D <sup>2</sup> Pak	D <sup>2</sup> Pak MSL1		
	Machine Model	Class M4 (425V)			
		AEC-Q101-002			
500	Human Body Model	Class H1C (2000V)			
ESD			AEC-Q101-001		
	Charged Device	Class C5 (1125V)			
	Model		AEC-Q101-005		
RoHS Compliant		Yes			

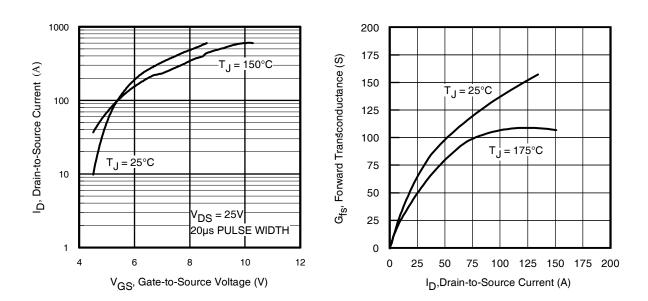
† Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

**††** Exceptions to AEC-Q101 requirements are noted in the qualification report.



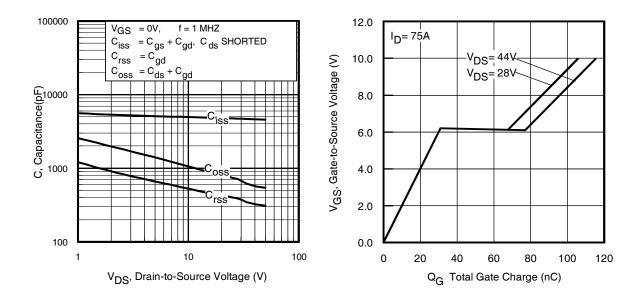
#### Fig 1. Typical Output Characteristics





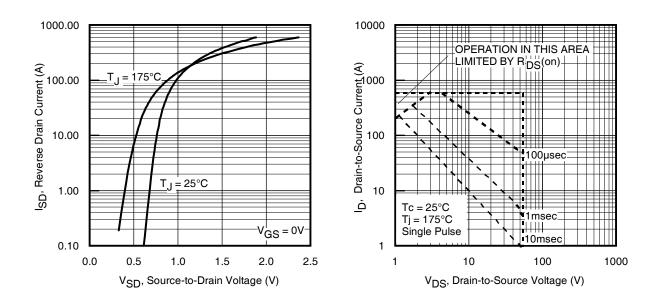
#### Fig 3. Typical Transfer Characteristics

Fig 4. Typical Forward Transconductance vs. Drain Current



#### Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

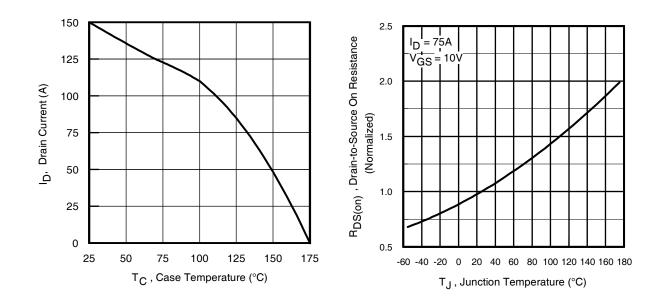




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Fig 7. Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area



#### Fig 9. Maximum Drain Current vs. Case Temperature

Fig 10. Normalized On-Resistance vs. Temperature

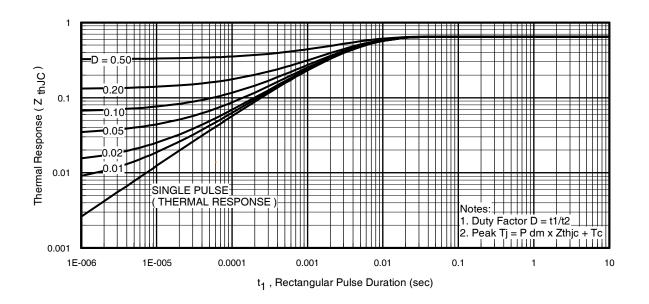


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

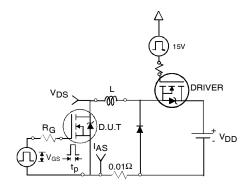


Fig 12a. Unclamped Inductive Test Circuit

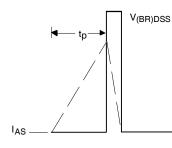
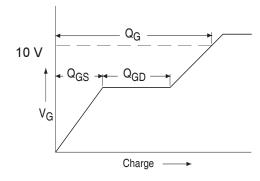
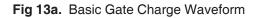
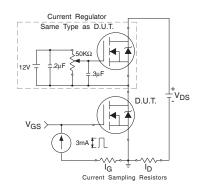


Fig 12b. Unclamped Inductive Waveforms







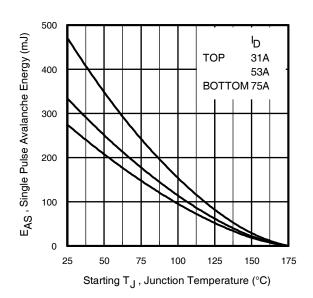


Fig 12c. Maximum Avalanche Energy vs. Drain Current

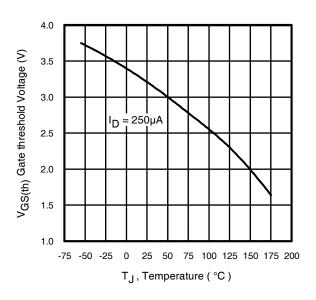


Fig 14. Threshold Voltage vs. Temperature

**Fig 13b.** Gate Charge Test Circuit www.irf.com

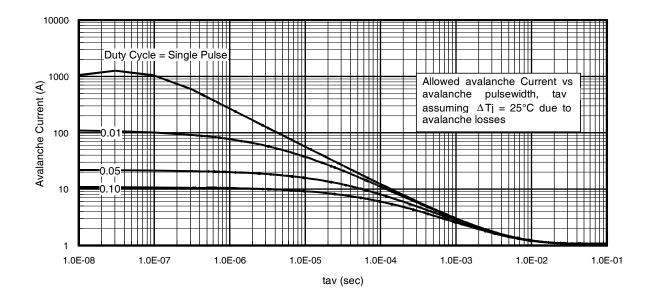
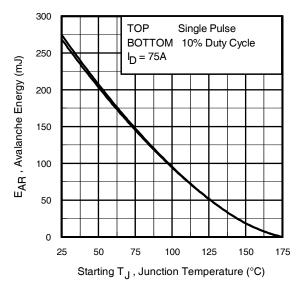


Fig 15. Typical Avalanche Current vs.Pulsewidth



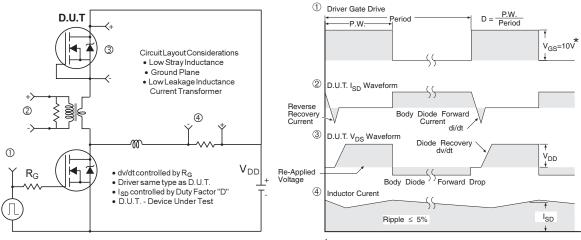
### Fig 16. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 15, 16: (For further info, see AN-1005 at www.irf.com) 1. Avalanche failures assumption:

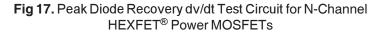
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.

- 2. Safe operation in Avalanche is allowed as long  $asT_{jmax}$  is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6.  $I_{av}$  = Allowable avalanche current.
- 7.  $\Delta$ T = Allowable rise in junction temperature, not to exceed T<sub>jmax</sub> (assumed as 25°C in Figure 15, 16).
  - $t_{av}$  = Average time in avalanche.
  - D = Duty cycle in avalanche =  $t_{av} \cdot f$
  - $Z_{thJC}(D, t_{av}) =$  Transient thermal resistance, see figure 11)

$$\begin{split} P_{D~(ave)} &= 1/2~(~1.3{\cdot}BV{\cdot}I_{av}) = {{\bigtriangleup}T/~Z_{thJC}}\\ I_{av} &= 2{{\bigtriangleup}T/~[1.3{\cdot}BV{\cdot}Z_{th}]}\\ E_{AS~(AR)} &= P_{D~(ave)}{\cdot}t_{av} \end{split}$$



\*  $V_{\rm GS}$  = 5V for Logic Level Devices



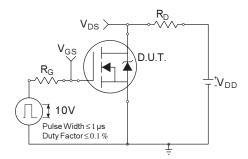


Fig 18a. Switching Time Test Circuit

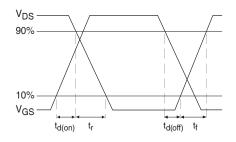
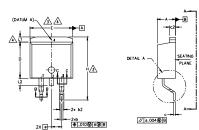


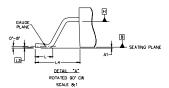
Fig 18b. Switching Time Waveforms

### D<sup>2</sup>Pak (TO-263AB) Package Outline

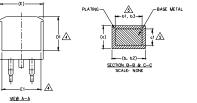
Dimensions are shown in millimeters (inches)







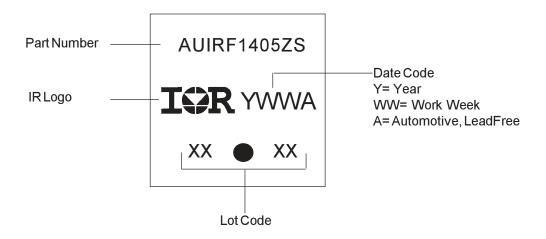
S Y B O	DIMENSIONS					
B	MILLIM	ETERS	TERS INCHES			
L	MIN.	MAX.	MIN.	MAX.	N O T E S	
A	4.06	4.83	.160	.190		
A1	0.00	0.254	.000	.010		
b	0.51	0.99	.020	.039		
b1	0.51	0.89	.020	.035	5	
b2	1,14	1.78	.045	.070		
ьз	1,14	1.73	.045	.068	5	
с	0.38	0.74	.015	.029		
c1	0.38	0.58	.015	.023	5	
c2	1,14	1.65	.045	.065		
D	8.38	9.65	.330	.380	3	
D1	6.86	-	.270		4	
E	9.65	10.67	.380	.420	3,4	
E1	6.22	-	.245		4	
e	2.54	BSC	.100	BSC		
н	14.61	15.88	.575	.625		
L	1,78	2,79	.070	.110		
L1	-	1.65	-	.066	4	
L2	-	1.78	-	.070		
L3	0.25	BSC	.010	BSC	]	
L4	4.78	5.28	.188	.208		



LEAD ASSIGNMENTS	
DIODES	
1 ANODE (TWO DIE) 2, 4 CATHODE 3 ANODE	) / OPEN (ONE DIE)
HEXFET	IGBTs. CoPACK
1 GATE 2, 4 DRAIN 3 SOURCE	1 GATE 2. 4 COLLECTO 3 EMITTER

	NOTES;	
	1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994	
	2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].	
	DIMENSION D & E DO NOT INCLUDE MOLD FLASH. WOLD FLASH SHALL NOT EXCEED 0.127 [LOOST] PER SDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.	
	A THERWAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.	
	S DIMENSION 61 AND c1 APPLY TO BASE WETAL ONLY.	
OR	6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.	
	7. CONTROLLING DIMENSION: INCH.	
	8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.	

### D<sup>2</sup>Pak (TO-263AB) Part Marking Information

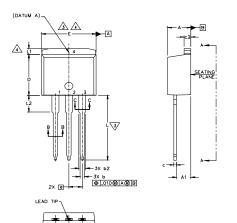


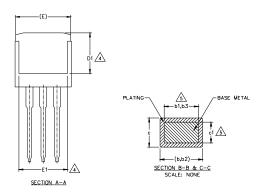
International **tor** Rectifier

# AUIRF1405ZS/L

### TO-262 Package Outline

Dimensions are shown in millimeters (inches)



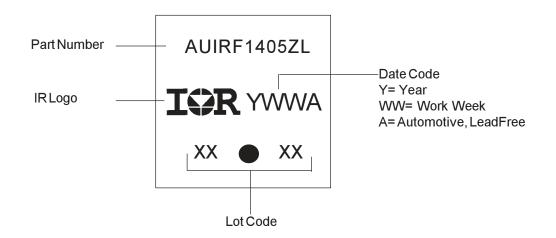


S Y			SIONS		
M		N			
B	MILLIM	ETERS	INC	HES	O T E S
Ľ	MIN.	MAX.	MIN.	MAX.	S
A	4.06	4.83	.160	.190	
A1	2.03	3.02	.080	.119	
ь	0.51	0.99	.020	.039	
Ь1	0.51	0.89	.020	.035	5
ь2	1.14	1.78	.045	.070	
ь3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	-	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	-	.245		4
е	2.54	BSC	.100	.100 BSC	
L	13.46	14.10	.530	.555	
∟1	-	1.65	-	.065	4
L2	3.56	3.71	.140	.146	

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4.- COLLECTOR HEXFEI DEODES 1.- GATE (- ANDE (11/0 DE) / 0FEN (0NE DE) 2.- DRAIN 2.4.- CATHODE 3.- SOURCE 3.- ANODE

#### TO-262 Part Marking Information

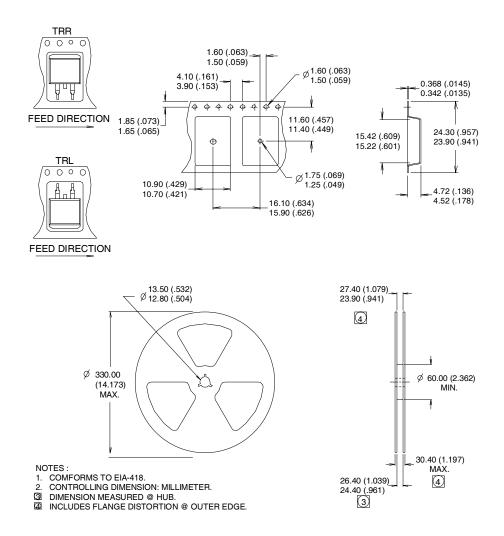


Note: For the most current drawing please refer to IR website at <u>http://www.irf.com/package/</u> www.irf.com Ī



### D<sup>2</sup>Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)





### Ordering Information

Base part	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRF1405ZL	TO-262	Tube	50	AUIRF1405ZL
AUIRF1405ZS	D2Pak	Tube	50	AUIRF1405ZS
		Tape and Reel Left	800	AUIRF1405ZSTRL
		Tape and Reel Right	800	AUIRF1405ZSTRR

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